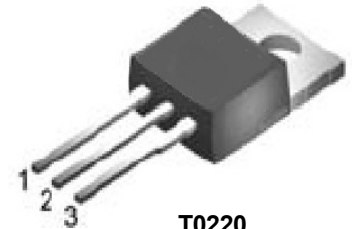
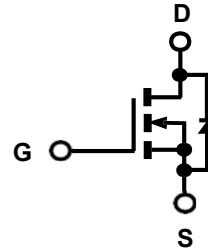


ICEK42NF60 N-Channel Enhancement Mode MOSFET

Features

- Low $r_{DS(on)}$
- Ultra Low Gate Charge
- High dv/dt capability
- High Unclamped Inductive Switching (UIS) capability
- High peak current capability
- Increased transconductance performance
- Optimized design for high performance power systems

Product Summary			
I_D	$T_A=25^\circ\text{C}$	42A	Max.
$V_{(BR)DSS}$	$I_D=1\text{mA}$	600V	Min.
$r_{DS(on)}$	$V_{GS}=10\text{V}$	45m Ω	Typ.
Q_g	$V_{DS}=400\text{V}$	95nC	Typ.



T0220

Standard Metal
Heatsink

1=Gate, 2=Drain,
3=Source.



Maximum ratings^a at $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ^b	I_D	$T_c=25^\circ\text{C}$	42	A
		$T_c=100^\circ\text{C}$	27	
Pulsed drain current ^b	$I_{D, pulse}$	$T_c=25^\circ\text{C}$	150	A
Avalanche energy, single pulse	E_{AS}	$L=10.8\text{mH}$, $V_{DD}=100\text{V}$, $I_{AS}=10\text{A}$, $R_G=50\Omega$	540	mJ
Avalanche current, repetitive ^b	I_{AR}	limited by $T_j\text{max}$	10	A
MOSFET dv/dt ruggedness	dv/dt	$V_{DS}=400\text{V}$, $I_D=42\text{A}$, $T_j=125^\circ\text{C}$	120	V/ns
Reverse diode dv/dt ruggedness			70	
Gate source voltage	V_{GS}	Static	± 20	V
		AC ($f>1\text{Hz}$)	± 30	
Power dissipation	P_{tot}	$T_c=25^\circ\text{C}$	250	W
Operating and storage temperature	T_j, T_{stg}		-55 to +150	$^\circ\text{C}$

^a Preliminary data sheet - Specifications subject to change.

^b limited by T_{jmax}

^c when mounted on 1-inch square 2oz copper-clad FR-4

Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	

Thermal characteristics

Thermal resistance, junction-case ^{a,c}	R_{thJC}		-	-	0.5	°C/W
Thermal resistance, junction-ambient ^{a,c}	R_{thJA}	leaded	-	-	55	
Soldering temperature, wave soldering only allowed at leads	T_{sold}	1.6mm (0.063in.) from case for 10 s	-	-	260	°C

Electrical characteristics ^a at $T_j=25^\circ\text{C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=1\text{ mA}$	600	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=1\text{ mA}$	3	3.8	5	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600\text{ V}, V_{GS}=0\text{ V}$	-	-	10	μA
Gate source leakage current	I_{GSS}	$V_{GS}=\pm 30\text{ V}, V_{DS}=0\text{ V}$	-	-	±100	nA
Drain-source on-state resistance	$r_{DS(on)}$	$V_{GS}=10\text{ V}, I_D=16\text{ A}$	-	45	58	mΩ
Gate resistance	R_G	$f=1\text{ MHz}$, open drain	-	6	-	Ω

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=400\text{ V}, f=1\text{ MHz}$	-	2890	-	pF
Reverse transfer capacitance	C_{riss}		-	15	-	
Output capacitance	C_{oss}		-	63	-	
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400\text{ V}, V_{GS}=13\text{ V}, I_D=16\text{ A}, R_G=3\Omega$ (External)	-	95	-	ns
Rise time	t_r		-	8	-	
Turn-off delay time	$t_{d(off)}$		-	83	-	
Fall time	t_f		-	8	-	

Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	

Gate charge characteristics

Gate to source charge	Q_{gs}	$V_{DS}=400V, I_D=16A,$ $V_{GS}=0 \text{ to } 10V$	-	16	-	nC
Gate to drain charge	Q_{gd}		-	50	-	
Gate charge total	Q_g		-	95	-	

Reverse Diode

Continuous forward current	I_S	$V_{GS}=0V$	-	-	42	A
Diode forward voltage	V_{SD}	$V_{GS}=0V, I_S=16A$	-	0.95	-	V
Reverse recovery time	t_{rr}	$V_{RR}=400V, I_S=16A,$ $d_{iF}/d_t=100 \text{ A}/\mu\text{S}$	-	90	-	ns
Reverse recovery charge	Q_{rr}		-	0.8	-	μC
Peak reverse recovery current	I_{rm}		-	16	-	A

a Preliminary data sheet - Specifications subject to change.

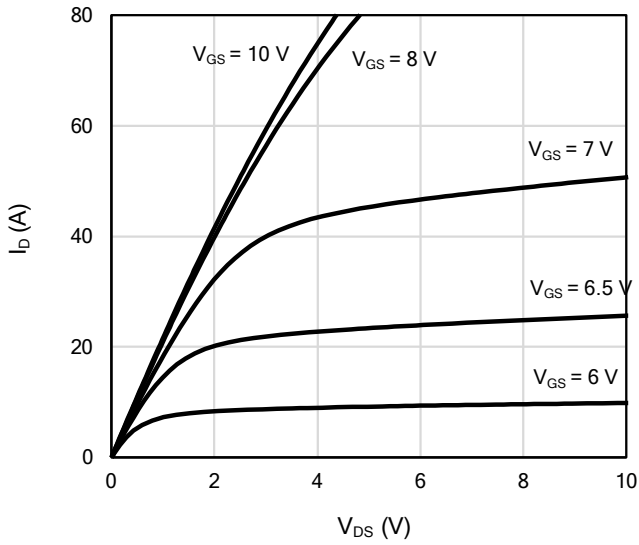


Figure 1: On-Region Characteristics

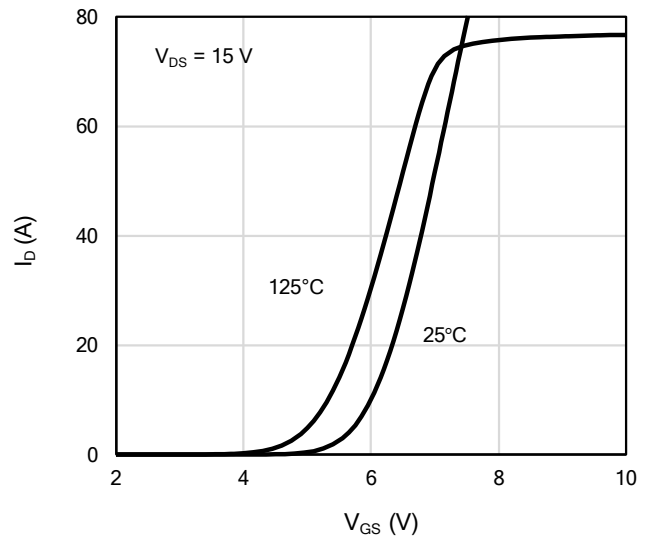


Figure 2: Transfer Characteristics

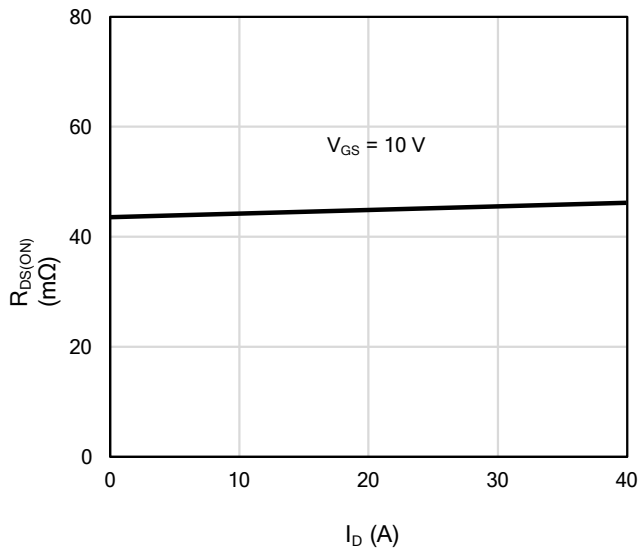


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

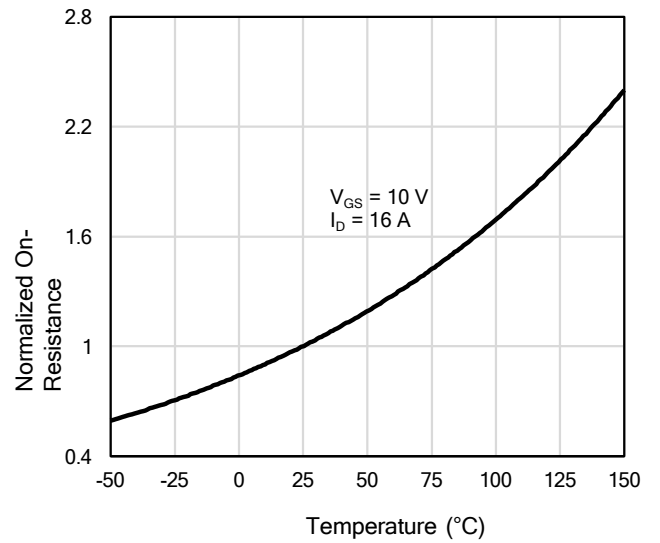


Figure 4: On-Resistance vs. Junction Temperature

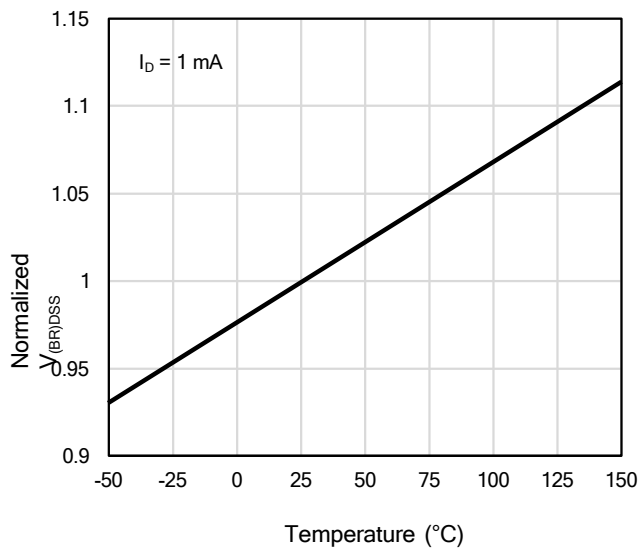


Figure 5: Breakdown Voltage vs. Junction Temperature

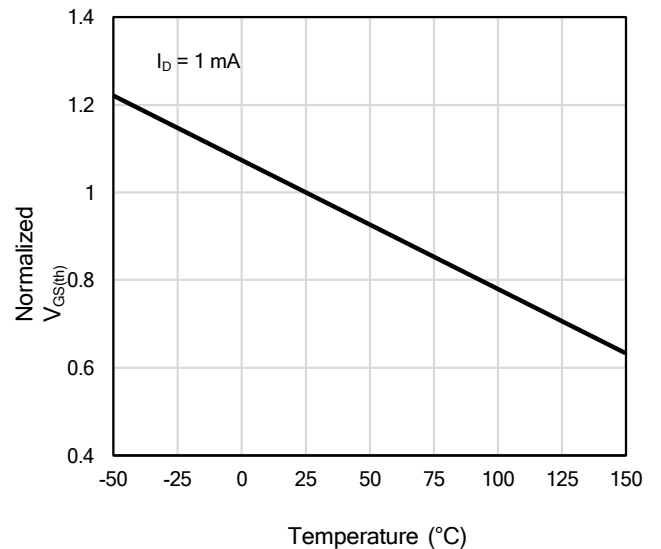


Figure 6: Threshold Voltage vs. Junction Temperature

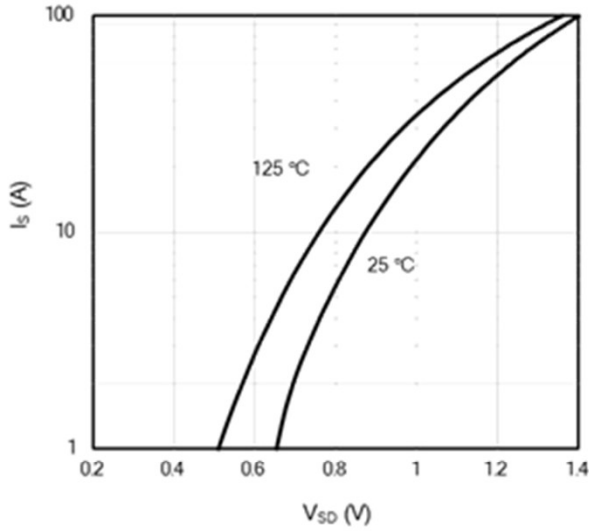


Figure 7: Body-Diode Characteristics

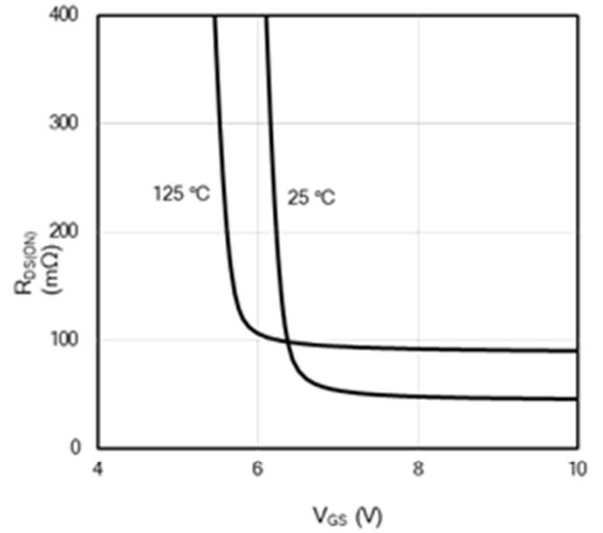


Figure 8: On-Resistance vs. Gate-Source Voltage

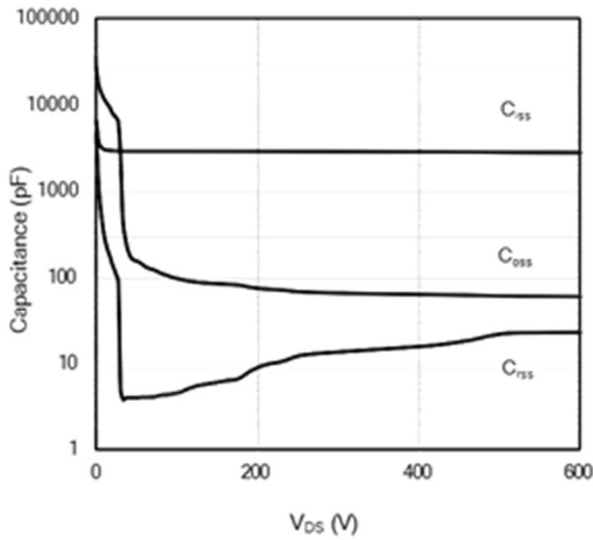


Figure 9: Capacitance Characteristics

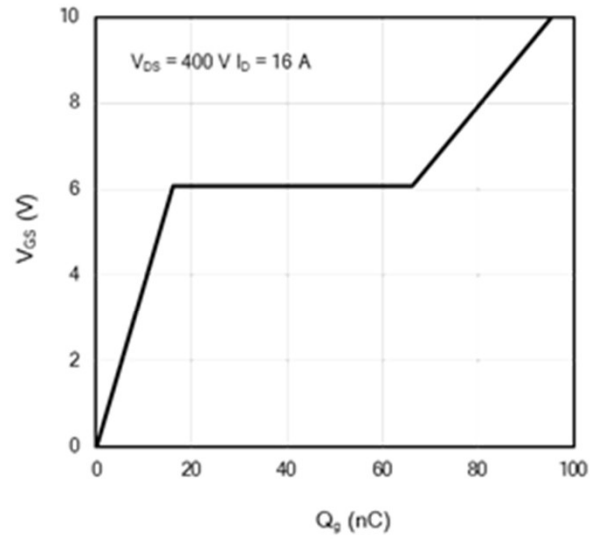


Figure 10: Gate-Charge Characteristics

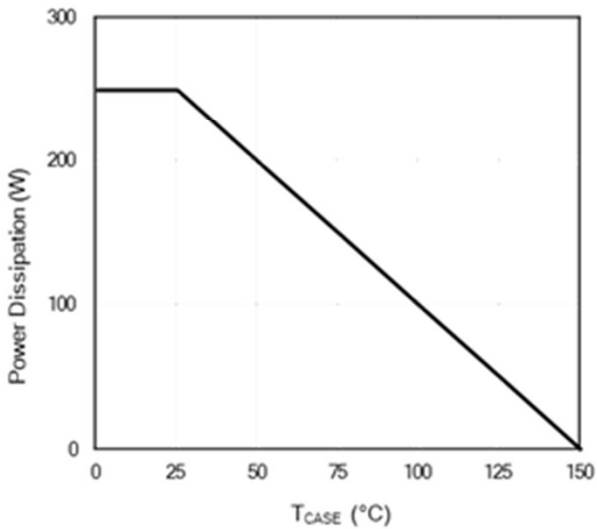


Figure 11: Power De-rating

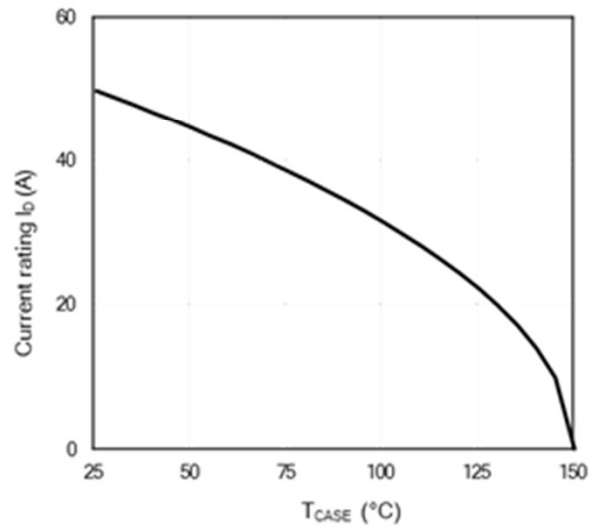


Figure 12: Current De-rating

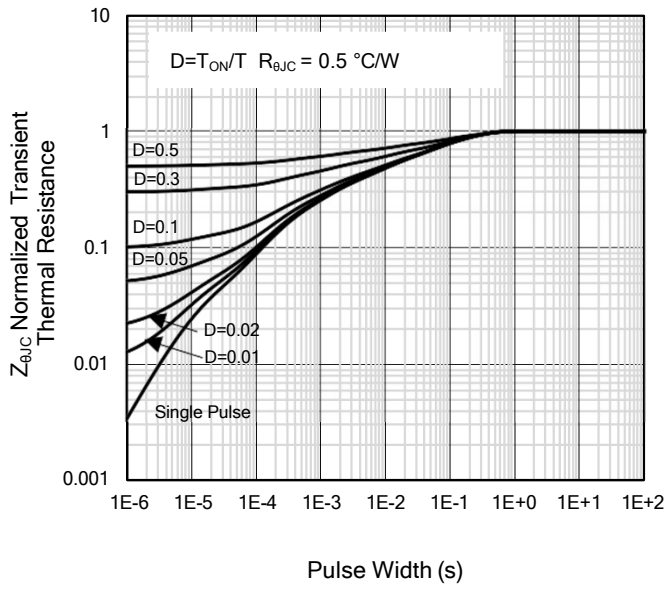


Figure 13: Normalized Maximum Transient Thermal Impedance

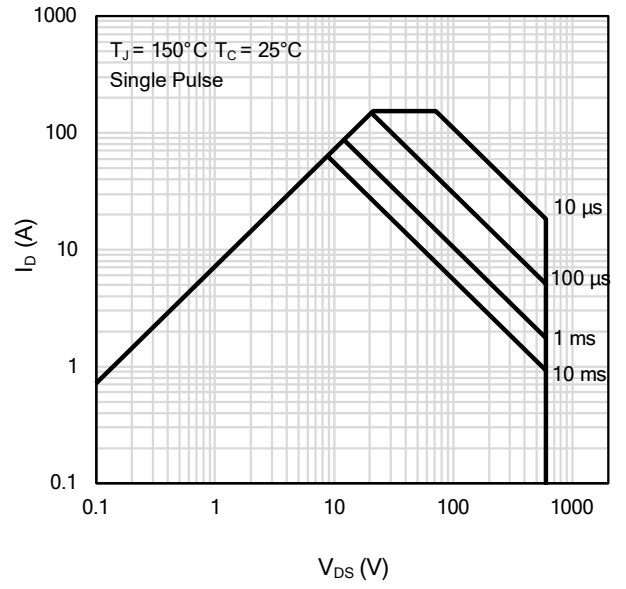


Figure 14: Maximum Forward Biased Safe Operating Area

Marking Information

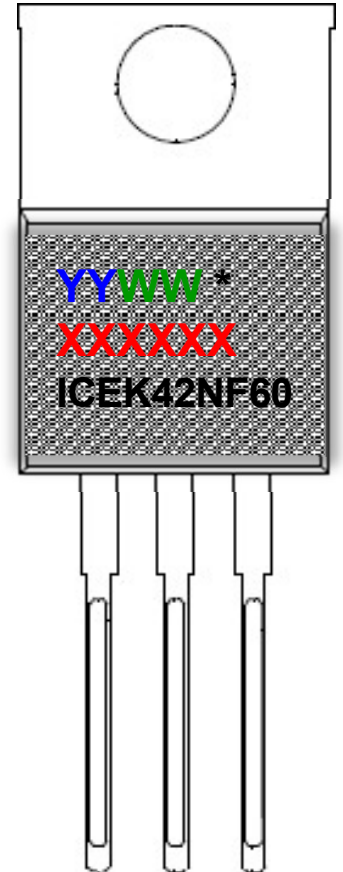
YY = Last two digits of the year

WW = Work week

***** = Site ID

XXXXXX = Lot ID

ICEK42NF60 = ICE is Icemos logo and
K42NF60 is a designated device part
number



Disclaimer

Information contained in this data sheet shall in no event be regarded as a guarantee of conditions or characteristics. All product, data sheet are subject to change without notice to improve reliability. ICEMOS technology will not be responsible for damages of any nature resulting from the use or reliance upon the information contained in this data sheet.

Revision record

Rev.0
04/17/2026

- Preliminary (deviations from AK3S60N580PMF datasheet listed below)
 - 1. Maximum I_D at $T_c=25^\circ\text{C}$ and $T_c=100^\circ\text{C}$ derated from 50A and 31A to 42A and 27A, respectively, due to P_{tot} limitations, remarked as “limited by T_{jmax} ”
 - 2. I_S decreased from 50A to 42A
 - 3. Note b) to the Pulsed Drain Current field added
 - 4. Note “when mounted on 1-inch square 2oz copper-clad FR-4” for the R_{thJC} and R_{thJA} fields included
 - 5. “Single Pulse” remarked into Figure 14: SOA
- Remark: ICEK42NF60 carries the same current rating as ICEK47NF60W, which was renamed to enable direct head-to-head comparison against the obsolete 47A MOSFET SPW47N60CFDFKSA, aligning with customer replacement requirements.